Sheet 1 of 1

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO.

APPLICATION NO.

IT AND TRADEMARK OFFICE 1614.1104

FIRST NAMED INVENTOR

Hideo MIYAKE et al.

December 15, 2000

FILING DATE

GROUP ART UNIT

(Use several sheets if necessary)

LIST OF REFERENCES CITED BY APPLICANT

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Sheet 1 of 1 APPLICATION NO. ATTORNEY DOCKET NO. FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE 09/736,357 1614.1104 FIRST NAMED INVENTOR LIST OF REFERENCES CITED BY APPLICANT Hideo MIYAKE et al. GROUP ART UNIT FILING DATE (Use several sheets if necessary) December 15, 2000 2183 **U.S. PATENT DOCUMENTS** DOCUMENT SUB-FILING *EXAMINER **CLASS** DATE INITIAL **CLASS** NO. DATE NAME AA 05/1998 Moreno et al. 5,758,051 *{*,c-AB 5,694,577 12/1997 Kiyohara et al. RECEIVED AC AD MAR 1 7 2003 ΑE Technology Center 2100 AF FOREIGN PATENT DOCUMENTS SUB-**TRANSLATION** DOCUMENT CLASS YES NO NO. COUNTRY **CLASS** DATE AG 2000-222207 08/2000 abs Japan AΗ ΑI AJ AK AL OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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